

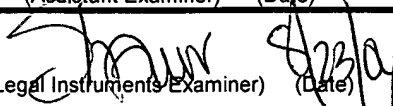


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/693,898	CHI, LI-WEN	
	Examiner	Art Unit	
	Richard K. Lee	2832	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
200		6R			200	4	332			
INTERNATIONAL CLASSIFICATION										
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----- (Assistant Examiner) (Date)		 Richard K. Lee 8/20/06 (Primary Examiner) (Date)	Total Claims Allowed: 1	
 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 4

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA					<input type="checkbox"/> T.D.					<input type="checkbox"/> R.1.47				
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